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DISTRIBUTION STATEMENT A. Approved for public release; distribution is unlimited.

1. SCOPE $1.1\,$ Scope. This drawing describes device requirements for class B microcircuits in accordance with $1.\overline{2.1}$ of MIL-STD-883, "Provisions for the use of MIL-STD-883 in conjunction with compliant non-JAN devices". 1.2 Part or Identifying Number (PIN). The complete PIN shall be as shown in the following example: 5962-88639 Drawing number Lead finish per (1.2.2)MIL-M-38510 1.2.1 Device type(s). The device type(s) shall identify the circuit function as follows: Device type Generic number Circuit function 01 54FCT573 Octal transparent latch with three-state outputs, TTL compatible 02 54FCT573A Octal transparent latch with three-state outputs, TTL compatible 1.2.2 Case outline(s). The case outline(s) shall be as designated in appendix C of MIL-M-38510, and as follows: Outline letter Case outline D-8 (20-lead, 1.060" x .310" x .200"), dual-in-line package F-9 (20-lead, .540" x .300" x .100"), flat package C-2 (20-terminal, .358" x .358" x .100"), square chip carrier package S 2 1.3 Absolute maximum ratings. 1/ -0.5 V dc to +7.0 V dc -0.5 V dc to V_{CC} +0.5 V dc -0.5 V dc to V_{CC} +0.5 V dc Output voltage range 2/- - - - - - - - - - - - - --20 mA ~50 mA ±100 mA 500 mW See MIL-M-38510, appendix C Storage temperature -65°C to +150°C +175 Lead temperature (soldering, 10 seconds) - - - -+300°C 1.4 Recommended operating conditions. +4.5 V dc to +5.5 V dc 0.8 V dc 2.0 V dc -55°C to +125°C Minimum setup time, high or low (D $_n$ to LE) (t $_s$)- - Minimum hold time, high or low (D $_n$ to LE) (t $_h$) - - Minimum LE pulse width, high or low (t $_w$) - - - -2.0 ns 1.5 ns 6.0 ns All voltages referenced to GND. For V_{CC} > 6.5 V dc, the upper bound is limited to V_{CC}. Must withstand the added P_D due to short circuit test; e.g., I_{OS}.

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STANDARDIZED

MILITARY DRAWING
DEFENSE ELECTRONICS SUPPLY CENTER

DAYTON, OHIO 45444

2. APPLICABLE DOCUMENTS

2.1 Government specification, standard, and bulletin. Unless otherwise specified, the following specification, standard, and bulletin of the issue listed in that issue of the Department of Defense Index of Specifications and Standards specified in the solicitation, form a part of this drawing to the extent specified herein.

SPECIFICATION

MILITARY

MIL-M-38510

- Microcircuits, General Specification for.

STANDARD

MILITARY

MIL-STD-883

Test Methods and Procedures for Microelectronics.

BULLETIN

MILITARY

MIL-BUL-103

- List of Standardized Military Drawings (SMD's).

(Copies of the specification, standard, and bulletin required by manufacturers in connection with specific acquisition functions should be obtained from the contracting activity or as directed by the contracting activity.)

- 2.2 Order of precedence. In the event of a conflict between the text of this drawing and the references cited herein, the text of this drawing shall take precedence.
 - REQUIREMENTS
- 3.1 Item requirements. The individual item requirements shall be in accordance with 1.2.1 of MIL-STD-883, "Provisions for the use of MIL-STD-883 in conjunction with compliant non-JAN devices" and as specified herein.
- 3.2 Design, construction, and physical dimensions. The design, construction, and physical dimensions shall be as specified in MIL-M-38510 and herein.
 - 3.2.1 Case outline(s). The case outline(s) shall be in accordance with 1.2.2 herein.
 - 3.2.2 Terminal connections. The terminal connections shall be as specified on figure 1.
 - 3.2.3 Truth table. The truth table shall be as specified on figure 2.
 - 3.2.4 Logic diagram. The logic diagram shall be as specified on figure 3.
- 3.3 Electrical performance characteristics. Unless otherwise specified herein, the electrical performance characteristics are as specified in table I and shall apply over the full case operating temperature range.
- 3.4 Electrical test requirements. The electrical test requirements shall be the subgroups specified in table II. The electrical tests for each subgroup are described in table I.
- 3.5 Marking. Marking shall be in accordance with MIL-STD-883 (see 3.1 herein). The part shall be marked with the PIN listed in 1.2 herein. In addition, the manufacturer's PIN may also be marked as listed in MIL-BUL-103 (see 6.6 herein).

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TABLE I. Electrical performance characteristics.								
Test	Symbol			 Group A subgroups	 Device type	Limi	ts	Unit
						Min	Max	
High level output voltage	, A ^{OH}	V _{IL} = 0.8 V	I _{OH} = ~300 μA	1, 2, 3	All	4.3		V
	 	V _{IH} = 2.0 V 	I _{OH} = -12 mA	1, 2, 3	All	2.4		
Low level output voltage	V _{OL}	$V_{T1} = 0.8 V$	I _{OL} = 300 μA	1, 2, 3	 A11 		0.2	V
	 	V _{IH} = 2.0 V	I _{OL} = 32 mA	1, 2, 3	All		0.5	T
Input clamp voltage	 A ^{IK} 	V _{CC} = 4.5 V,	I _N = -18 mA	1	A71		-1.2	V
High level input current	I IH	V _{CC} = 5.5 V,	V _{IN} = 5.5 V	1, 2, 3	All		5.0	μ Α
Low level input current	I I I I I I I I I I I I I I I I I I I	V _{CC} = 5.5 V,	V _{IN} = GND	1, 2, 3	 All 		-5.0	
Short circuit output current	1 0S	V _{CC} = 5.5 V	1/	1, 2, 3	A11	-60	 	mA
Quiescent power supply current (CMOS inputs)	I CCQ	$V_{IN} \le 0.2 V_{CC} = 0.00$	or V _{IN >} 5.3 V = 5.5 V	1, 2, 3	All		1.5	 mA
Quiescent power supply current (TTL inputs)	ΔI _{CC}	V _{CC} = 5.5 V,	$V_{IN} = 3.4 \text{ V}$	1, 2, 3	All		2.0	
Dynamic power supply current	ICCD	$V_{IN} < 0.2 V$, $\overline{\text{OE}}$ = $\check{\text{GND}}$, one bit	 <u>3/</u> 	All		0.4	mA/MHz

See footnotes at end of table.

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·	TABLE I.	Electrical performance character	ristics - 0	Continue	d.		_
Test	 Symbol		 Group A subgroups	 Device type	Limi	Unit	
·		$V_{CC} = 5.0$ V dc ± 10 % unless otherwise specified			Min	Max	
Total power supply current 4/	Icc	$\begin{array}{c} \text{VCC} = 5.5 \text{ V, } \text{fcp} = 10 \text{ MHz,} \\ \text{outputs open,} \text{V}_{\text{IN}} \geq 5.3 \text{ V or} \\ \text{V}_{\text{IN}} < 0.2 \text{ V, } \text{OE} = \overline{\text{GND,}} \\ \text{LE} = \text{V}_{\text{CC}}, \text{ one bit toggling } \sim \\ 50\% \text{ duty cycle} \end{array}$	1, 2, 3	All		5.5	mA mA
	! 	V _{CC} = 5.5 V, f _{CP} = 10 MHz, outputs open, V _{IN} = 3.4 V or V _{IN} = GND, OE = GND, LE = V _{CC} , eight bit toggling ~ 50% duty cycle	1, 2, 3	All		6.0 	 - - - -
Functional tests		See 4.3.1c	7,8	All]]]
Input capacitance	CIN 	See 4.3.1d	4	All		10	pF
Output capacitance	COUT	See 4.3.1d	4	All		12	pF
Propagation delay	t _{PLH1} ,	C _L = 50 pF	9,10,11	01	1.0	8.5	ns
time, D _n to O _n	t _{PHL1}	$R_{L} = 500\Omega$ See figure 4 <u>5</u> /		02	1.0	5.6	
Propagation delay time, LE to O _n	t _{PLH2} ,		9,10,11	01	1.0	15.0	 ns
time, Lt to on	tPHL2			02	1.0	9.8	
Output enable time			 9,10,11 	01	1.0	13.5	l ns
	t _{PZL}	-		02	1.0	7.5	
Output disable time	t _{PHZ} ,		 9,10,11	01	1.0	10.0	ns
	72.2	•	i '	02	1.0	6.5	ļ

¹/ Not more than one output should be shorted at one time and the duration of the short circuit condition should not exceed 1 second.

- 2/ In accordance with TTL driven input ($V_{IN} = 3.4 \text{ V dc}$); all other outputs at V_{CC} or GND.
- This parameter is not directly testable, but is derived for use in total power supply calculations.
- $\begin{array}{l} ^{I}\text{CC} = \overset{I}{\text{CCO}} + (\overset{\Delta I}{\text{CCC}} \overset{X}{\text{D}_{H}} \overset{X}{\text{N}} \overset{N_{T}}{\text{N}}) + (\overset{I}{\text{CCD}} \overset{X}{\text{F}} \overset{X}{\text{N}} \overset{N_{I}}{\text{N}}) \\ \overset{N_{T}}{\text{E}} = \overset{\text{duty cycle for TTL inputs at D}_{\text{H}}. \\ & \overset{f}{\text{I}} = \overset{\text{input frequency in MHz.}}{\text{N}} & \overset{N_{I}}{\text{I}} = \overset{\text{number of inputs at f}}{\text{I}}. \\ \end{array}$
- $\underline{5}/$ Minimum limits shall be guaranteed, if not tested, to the limits of table I.

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Device types	s 01 and 02					
Case outlines	R, S, and 2					
Terminal number	Terminal symbol					
1	<u>OE</u>					
2	D _O					
3	D ₁					
4	D ₂					
5	D ₃					
6	D ₄					
7	D ₅					
8	D ₆					
9	D ₇					
10	i GND					
11	LE					
12	07					
13	06					
14	05					
15	04					
16	03					
17	02					
18	01					
19	o ₀					
20	V _{CC}					

FIGURE 1. Terminal connections.

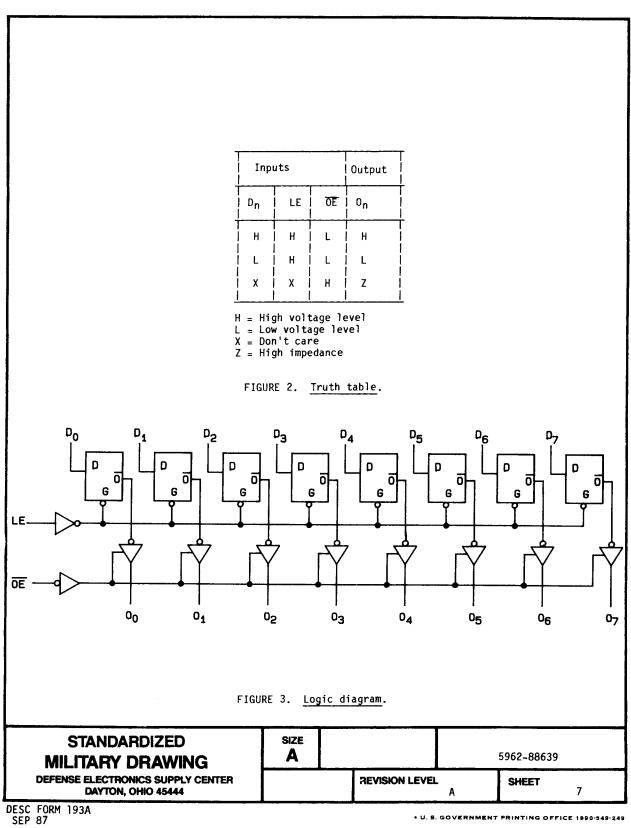
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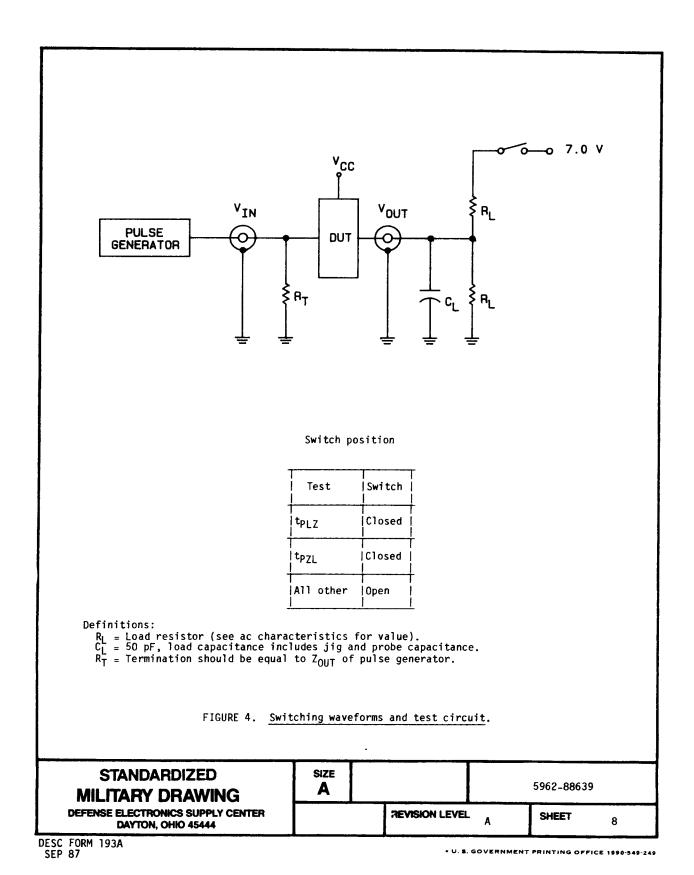
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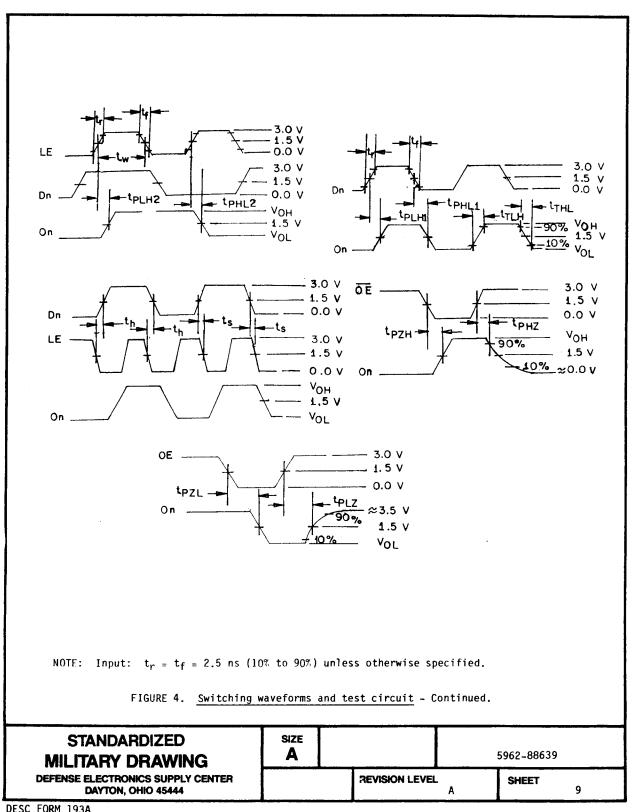
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- 3.6 Certificate of compliance. A certificate of compliance shall be required from a manufacturer in order to be listed as an approved source of supply in MIL-BUL-103 (see 6.6 herein). The certificate of compliance submitted to DESC-ECS prior to listing as an approved source of supply shall affirm that the manufacturer's product meets the requirements of MIL-STD-883 (see 3.1 herein) and the requirements herein.
- 3.7 Certificate of conformance. A certificate of conformance as required in MIL-STD-883 (see 3.1 herein) shall be provided with each lot of microcircuits delivered to this drawing.
- 3.8 Notification of change. Notification of change to DESC-ECS shall be required in accordance with MIL-SID-883 (see 3.1 herein).
- 3.9 Verification and review. DESC, DESC's agent, and the acquiring activity retain the option to review the manufacturer's facility and applicable required documentation. Offshore documentation shall be made available onshore at the option of the reviewer.
 - 4. QUALITY ASSURANCE PROVISIONS
- 4.1 Sampling and inspection. Sampling and inspection procedures shall be in accordance with section 4 of MIL-M-38510 to the extent specified in MIL-STD-883 (see 3.1 herein).
- 4.2 Screening. Screening shall be in accordance with method 5004 of MIL-STD-883, and shall be conducted on all devices prior to quality conformance inspection. The following additional criteria shall apply:
 - a. Burn-in test, method 1015 of MIL-STD-883.
 - Test condition A, B, C, or D using the circuit submitted with the certificate of compliance (see 3.6 herein).
 - (2) $T_A = +125$ °C, minimum.
 - b. Interim and final electrical test parameters shall be as specified in table II herein, except interim electrical parameter tests prior to burn-in are optional at the discretion of the manufacturer.
- 4.3 Quality conformance inspection. Quality conformance inspection shall be in accordance with method $\overline{5005}$ of MIL-STD-883 including groups A, B, C, and D inspections. The following additional criteria shall apply.
 - 4.3.1 Group A inspection.
 - a. Tests shall be as specified in table II herein.
 - b. Subgroups 5 and 6 in table I, method 5005 of MIL-STD-883 shall be omitted.
 - c. Subgroups 7 and 8 shall include verification of the truth table.
 - d. Subgroup 4 (C_{IN} and C_{OUT} measurements) shall be measured only for the initial test and after process or design changes which may affect input capacitance. Capacitance shall be measured between the designated terminal and GND at a frequency of 1 MHz. Test all applicable pins on five devices with zero failures.

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TABLE II. Electrical test requirements.

MIL-STD-883 test requirements	Subgroups (per method 5005, table I)
Interim electrical parameters (method 5004)	
Final electrical test parameters (method 5004)	1*, 2, 3, 7, 8, 9, 10, 11
Group A test requirements (method 5005)	1, 2, 3, 4, 7, 8, 9, 10, 11
Groups C and D end-point electrical parameters (method 5005)	1, 2, 3

PDA applies to subgroup 1.

4.3.2 Groups C and D inspections.

- a. End-point electrical parameters shall be as specified in table II herein.
- b. Steady-state life test conditions, method 1005 of MIL-STD-883.
 - (1) Test condition A, B, C, or D using the circuit submitted with the certificate of compliance (see 3.6 herein).
 - (2) $T_A = +125$ °C, minimum.
 - (3) Test duration: 1,000 hours, except as permitted by method 1005 of MIL-STD-883.

5. PACKAGING

5.1 Packaging requirements. The requirements for packaging shall be in accordance with MIL-M-38510.

6. NOTES

- 6.1 <u>Intended use</u>. Microcircuits conforming to this drawing are intended for use when military specifications do not exist and qualified military devices that will perform the required function are not available for OEM application. When a military specification exists and the product covered by this drawing has been qualified for listing on QPL-38510, the device specified herein will be inactivated and will not be used for new design. The QPL-38510 product shall be the preferred item for all applications.
- 6.2 Replaceability. Microcircuits covered by this drawing will replace the same generic device covered by a contractor-prepared specification or drawing.

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6.3 Configuration control of SMD's. All with the users of record for the individual accordance with MIL-STD-481 using DD Form 1	documents. This c	oordination will be	accomplished in
6.4 Record of users. Military and indus when a system application requires configur a record of users and this list will be use drawings. Users of drawings covering micro telephone (513) 296-6022.	ation control and t i for coordination	he applicable SMD. and distribution of	DESC will maintain changes to the
6.5 Comments. Comments on this drawing telephone (513) 296-5375.	should be directed	to DESC-ECS, Dayton	, Ohio 45444, or
6.6 Approved sources of supply. Approve vendors listed in MIL-BUL-103 have agreed therein) has been submitted to and accepted	this drawing and		
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